

Supporting Information: Bright and ultrafast electron point source made of LaB₆ nanotip.

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Supporting Information Available

Measure of electron current as a function of laser power and polarization angle

We measure the emitted current as function of the laser intensity at V=100V, in the MPP regime. The linear behavior reported on the log-log scale (see Fig. S1) can be fitted by the power law $I \propto P_{laser}^n$ with $n = 3.6 \pm 0.1$.

We measure the emitted current as function of the angle α between the electric field of the laser and the major axis of the field emitter, in the MPP regime (see Fig.S2). The fit by a sinusoidal function $I \propto (\cos(\alpha))^{2n}$ with $n = 5$ shows that in the MPP regime a mean number of 5 photons is involved in the emission process.

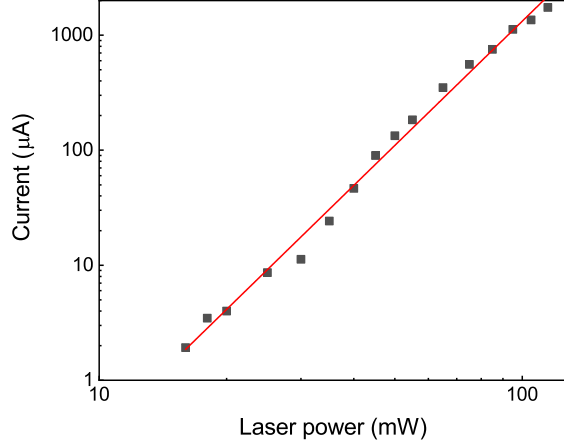


Figure S1: Electron current as a function of laser power (black square) at $V=100V$ and fit (red line) using a power law: $I \propto P_{laser}^n$ with $n = 3.6 \pm 0.1$, indicating the MMP emission process.

Emission pattern and energy spectra in the MMP regime at low laser intensity

We report in Fig.S3 the FEM pattern at $V=300V$ and $I=5 \text{ GW/cm}^2$ and the energy spectra for each area indicated by a yellow circle. The main emission is from region R5 corresponding to the (001) pole. The energy spectra show a lower energy for electrons from region R5 due to the lower work function of (001) pole compared to (011) poles.

Brightness calculation

The Fig.S4 shows the set-up dimensions, the electron trajectories, the associated effective radius r_v and the semi-angle of divergence α . The m factor, known as the projection point factor, is calculated measuring on the screen the distance D between the central $\langle 001 \rangle$ pole and the $\langle 110 \rangle$ pole on a FIM image. Because for a cubic crystal the angular distance

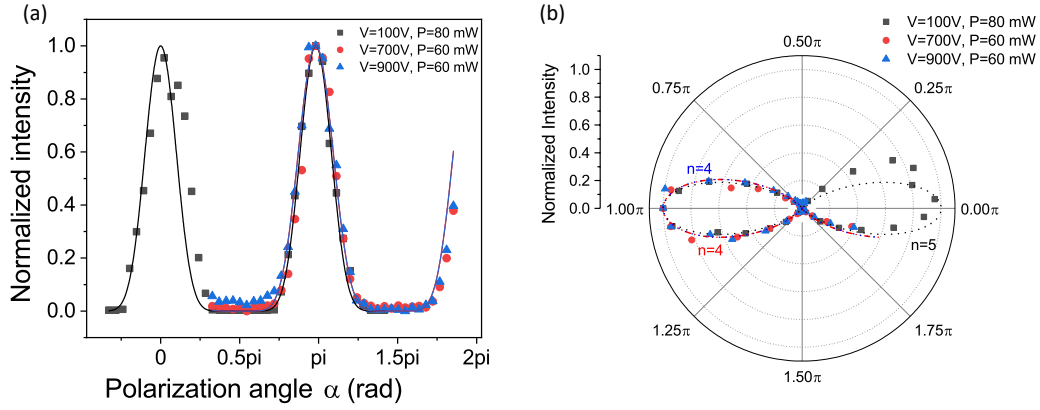


Figure S2: (a) Linear and (b) polar representation of emitted current as a function of the angle α between the electric field of the laser and the major axis of the field emitter.

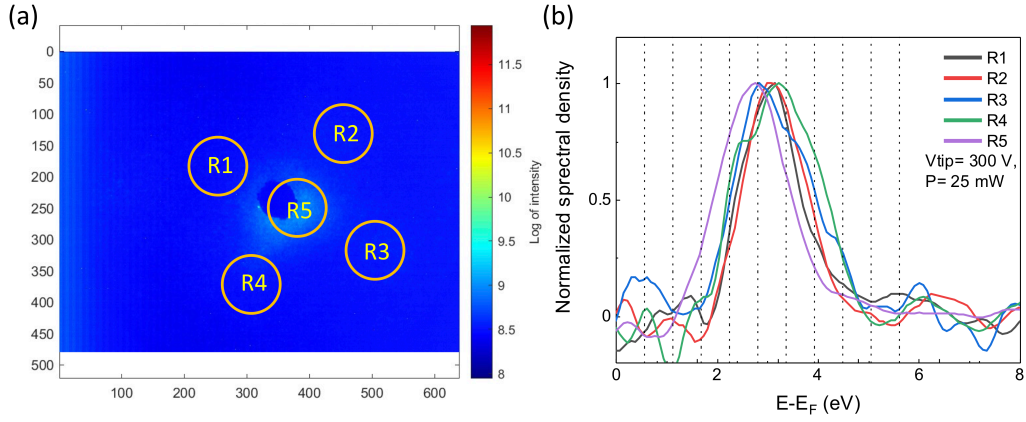


Figure S3: (a) FEM pattern at $V=300\text{V}$ and $I=5\text{ GW}/\text{cm}^2$. (b) Energy spectra for each area indicated by a yellow circle in (a) at $V=300\text{V}$ and $I=5\text{ GW}/\text{cm}^2$.

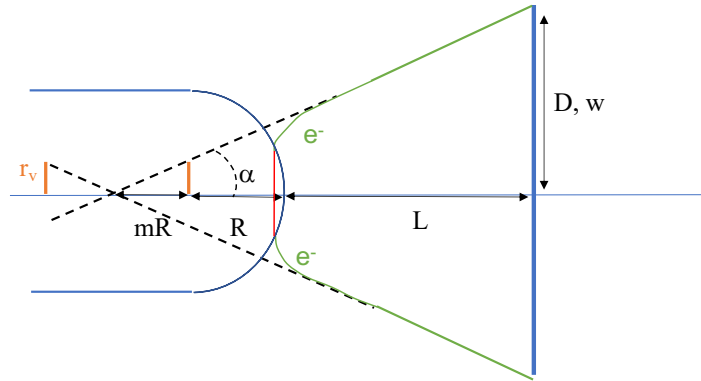


Figure S4: Electron trajectory diagram showing the set-up dimensions and the definition of the effective radius r_v for the emission area.

between these two poles is 45° we obtain:

$$m + 1 = \frac{45}{\arctan(D/L)}$$

with L the tip-screen distance. For $D = 3\text{cm}$ and $L = 6.5\text{ cm}$, $m = 0.8$.

The solid angle is calculated as: $\theta = 2\pi(1 - \cos(\alpha))$, with

$$\alpha = \arctan(w/L),$$

where $w = \frac{1}{2}$ FWHM of the gaussian profile of the emission spot. The physical radius of the electron source is calculated as:

$$r_v = mR \tan(\alpha)$$

and the physical source size as: $S_v = \pi * r_v^2$. The brightness is:

$$B = \frac{I}{\pi r_v^2 \theta},$$

with I the emitted current. For static emission we measure current up to 10 nA, using a picoammeter between the high voltage power supply and the sample. However, due to the limitation of our detector, we can not register the associated FEM images.

Table 1: default

Voltage (V)	Power (mW)	Current (pA)	FWHM (mm)	α (rad)	θ (sr)	r_v (nm)	$B \times 10^9$ A/(m ² Sr ¹)
Sample 1							
660	0	0.5	4	0.03	0.003	0.246	0.88
800	0	6	7	0.05	0.009	0.430	1.13
400	40	0.25	7	0.05	0.009	0.430	0.047
Sample 2							
465	0	0.1	4	0.03	0.003	0.246	0.17
485	0	0.25	5	0.038	0.0046	0.307	0.18
565	0	5	6	0.046	0.0067	0.370	1.75

For lower current values, we measure the current on the phosphor screen I_{screen} and then we calculated the emitted current dividing I_{screen} by the detector gain-factor G . The gain-factor was measured at low emission currents, counting individual impacts on the screen. For an MCP voltage of 1550 V, $G = 10^7$. The values of current and the corresponding brightness are reported on the Table. For example, at a voltage of 565V we measured a current of 5pA, a semi-angle of divergence of 0.046 rad, an effective radius of 0.37 nm and a brightness of $1.75 \times 10^9 \text{ Am}^{-2}\text{Sr}^{-1}$. These value is lower than what was reported in the recent works on the emission from LaB₆, however, if we suppose that the solid angle of emission stays almost stable increasing the applied voltage from 500V to 850V and the emitted current from 5 pA to 10 nA, then we obtain a brightness of $10^{12} \text{ Am}^{-2}\text{Sr}^{-1}$ close to the values reported in the literature.